Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10593786	KANO ET AL.
Examiner	Art Unit
JON M LOCKARD	1647

SEARCHED						
Class	Subclass	Date	Examiner			
NONE		3/25/11	JML			

SEARCH NOTES				
Search Notes	Date	Examiner		
STIC Search of SEQ ID NOs:1-2. See sequence search results in SCORE.	3/25/11	JML		
EAST (USPAT, US-PGPUB, EPO, DERWENT): See attached search history.	3/25/11	JML		
STN (MEDLINE, SCISEARCH, EMBASE, BIOSIS): See attached search history.	3/25/11	JML		
PALM: Inventor search.	3/25/11	JML		
STIC Search of SEQ ID NOs:1-2. See sequence search results in SCORE.	11/29/2011	JML		
EAST (USPAT, US-PGPUB, EPO, DERWENT): See attached search history.	11/29/2011	JML		
PALM: Inventor search.	11/29/2011	JML		

INTERFERENCE SEARCH					
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